## Application/Control No. 10/073,201 Applicant(s)/Patent Under Reexamination IWAMI ET AL. Examiner Gary Chin Applicant(s)/Patent Under Reexamination IWAMI ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,336,073	01-2002	Ihara et al.	701/202
	В	US-6,219,614	04-2001	Uchigaki et al.	701/211
	C	US-6,415,224	07-2002	Wako et al.	701/208
	D	US-5,774,828	06-1998	Brunts et al.	701/210
	Е	US-6,622,089	09-2003	Hasegawa et al.	701/211
	F	US-6,571,169	05-2003	Miyaki, Ken	701/200
	G	US-6,542,814	04-2003	Polidi et al.	701/208
	π	US-6,374,183	04-2002	Oshida et al.	701/211
		US-6,333,702	12-2001	Hiyokawa et al.	340/995.21
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	α					
	R					
	S					
	Т	·				

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	υ					
	٧					
	w					
	x					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

1